



100-X Micron Star

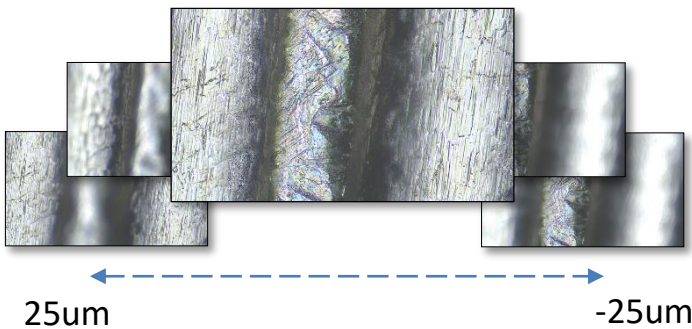


同軸光束系統

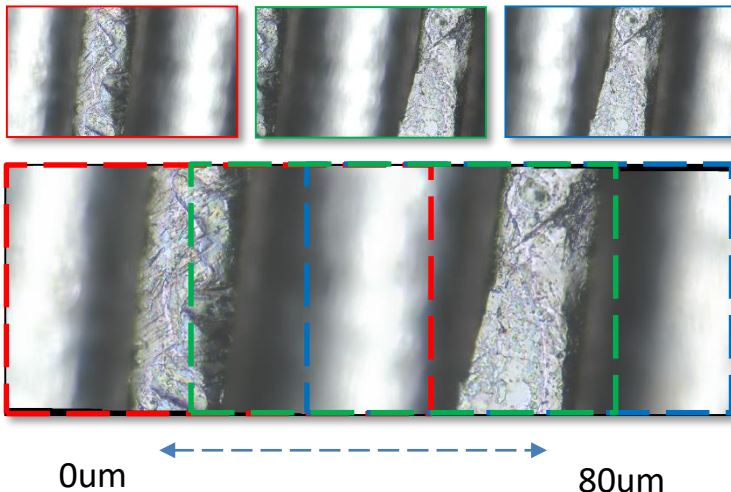
- 易觀察景深疊圖與量測
- 便利式縫合大尺寸樣品
- 無需攜帶電腦操作量測



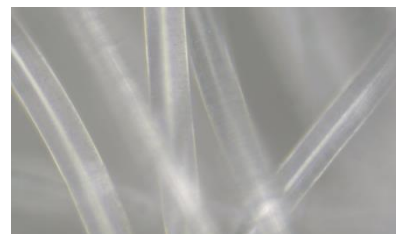
● 景深疊圖及景深量測(z)



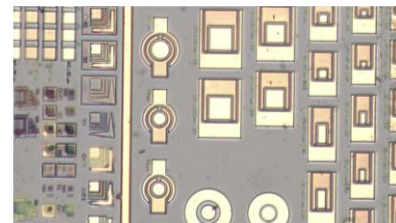
● 圖像縫合及距離量測(x,y)



● 實際樣品拍攝應用



明視野
纖維樣品



電子電路
檢測系統